



SHEET 1 OF 9

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(Substitute for form 1449/PTO)

ATTY. DOCKET NO.  
**070456-0122**SERIAL NO.  
**10/585,646**APPLICANT  
**Yasuyuki WATANABE, et al.**FILING DATE  
**July 07, 2006**GROUP  
**Not Yet Assigned****U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code <sup>3</sup> -Number 4-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes      No	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
		JIS Z 2242 "Method of impact test for metallic materials", Published by Japanese Standards Association, December 21, 1998					
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		BURRIER, JR., H., "Hardenability of Carbon and Low-Alloy Steels", 2002, ASM International					
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		US Office Action, issued in US Patent Application No. 10/686,766, dated on November 7, 2007					
		US Office Action, issued in US Patent Application No. 10/787,221, dated on October 26, 2007					
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